

## U74LVC1G00

CMOS IC

## SINGLE 2-INPUT NAND GATE

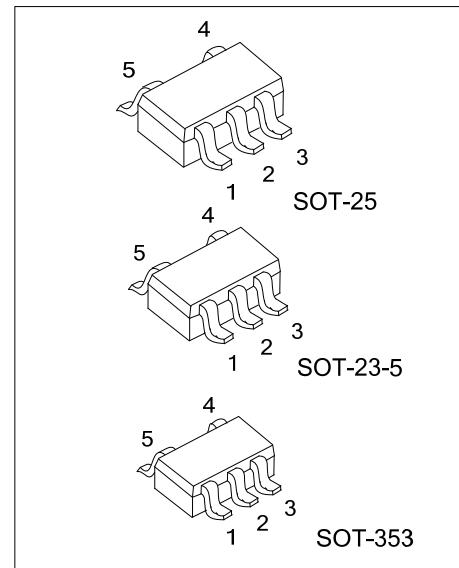
## ■ DESCRIPTION

The **U74LVC1G00** is a 2-input NAND gate device which provides the Function  $Y=A \bullet B$  or  $Y=\overline{A} + \overline{B}$  in positive logic.

This device has power-down protective circuit preventing device from destruction when it is powered down.

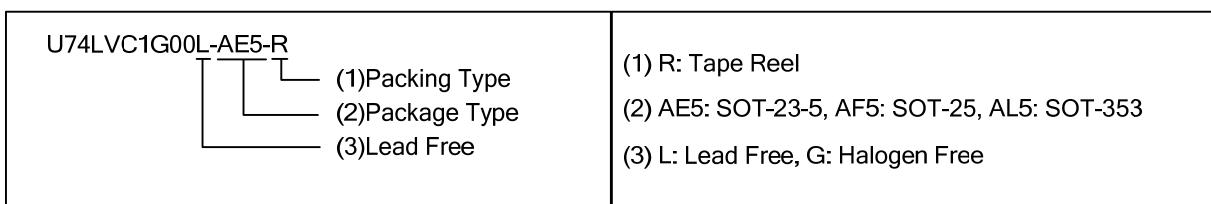
## ■ FEATURES

- \* Operate From 1.65V to 5.5V
- \* Inputs Accept Voltages To 5.5V
- \* High Noise Immunity
- \* Low Power Dissipation
- \* Max  $t_{PD}$  of 3.8 ns at 3.3V

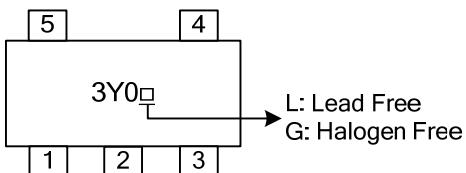


## ■ ORDERING INFORMATION

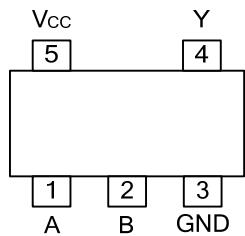
Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74LVC1G00L-AE5-R	U74LVC1G00G-AE5-R	SOT-23-5	Tape Reel
U74LVC1G00L-AF5-R	U74LVC1G00G-AF5-R	SOT-25	Tape Reel
U74LVC1G00L-AL5-R	U74LVC1G00G-AL5-R	SOT-353	Tape Reel



## ■ MARKING



## ■ PIN CONFIGURATION

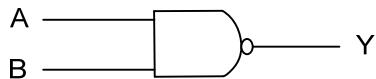


## ■ FUNCTION TABLE

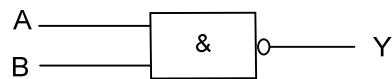
INPUT(A)	INPUT(B)	OUTPUT(Y)
H	H	L
H	L	H
L	H	H
L	L	H

Note: H: HIGH voltage level; L: LOW voltage level.

## ■ LOGIC DIAGRAM (positive logic)



Logic symbol



IEC logic symbol

■ ABSOLUTE MAXIMUM RATING (unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Supply Voltage		V <sub>CC</sub>	-0.5 ~ +6.5	V
Input Voltage		V <sub>IN</sub>	-0.5 ~ +6.5	V
Output Voltage	Output in the high or low state	V <sub>OUT</sub>	-0.5 ~ +0.5	V
	Output in the high-impedance or power-off state		-0.5 ~ +6.5	V
V <sub>CC</sub> or GND Current (Output in the power-off state)	I <sub>CC</sub>		±100	mA
Continuous Output Current (V <sub>OUT</sub> =0 to V <sub>CC</sub> )	I <sub>OUT</sub>		±50	mA
Input Clamp Current (V <sub>IN</sub> <0)	I <sub>IK</sub>		-50	mA
Output Clamp Current (V <sub>OUT</sub> <0)	I <sub>OK</sub>		-50	mA
Storage Temperature Range	T <sub>STG</sub>		-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	SOT-23-5	θ <sub>JA</sub>	280	°C/W
	SOT-25		230	
	SOT-353		350	

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V <sub>CC</sub>	Operating	1.65		5.5	V
		Data retention only	1.5			V
Input Voltage	V <sub>IN</sub>		0		5.5	V
Output Voltage	V <sub>OUT</sub>	High or low state	0		V <sub>CC</sub>	V
High-level Output Current	I <sub>OH</sub>	V <sub>CC</sub> =1.65V			-4	mA
		V <sub>CC</sub> =2.3V			-8	mA
		V <sub>CC</sub> =3V			-16	mA
		V <sub>CC</sub> =3V			-24	mA
		V <sub>CC</sub> =4.5V			-32	mA
Low-level Output Current	I <sub>OL</sub>	V <sub>CC</sub> =1.65V			4	mA
		V <sub>CC</sub> =2.3V			8	mA
		V <sub>CC</sub> =3V			16	mA
		V <sub>CC</sub> =3V			24	mA
		V <sub>CC</sub> =4.5V			32	mA
Operating Temperature	T <sub>A</sub>		-40		85	°C
Input Transition Rise or Fall Rate	t <sub>R</sub> / t <sub>F</sub>	V <sub>CC</sub> =1.8V±0.15V, 2.5V±0.2V			20	ns/V
		V <sub>CC</sub> =3.3V±0.3V			10	ns/V
		V <sub>CC</sub> =5V±0.5V			5	ns/V

■ ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ C$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
High-Level Input Voltage	$V_{IH}$	$V_{CC}=1.65V \sim 1.95V$		$0.65*V_{CC}$			V
		$V_{CC}=2.3V \sim 2.7V$		1.7			V
		$V_{CC}=3V \sim 3.6V$		2			V
		$V_{CC}=4.5V \sim 5.5V$		$0.7*V_{CC}$			V
Low-Level Input Voltage	$V_{IL}$	$V_{CC}=1.65V \sim 1.95V$			$0.35*V_{CC}$		V
		$V_{CC}=2.3V \sim 2.7V$			0.7		V
		$V_{CC}=3V \sim 3.6V$			0.8		V
		$V_{CC}=4.5V \sim 5.5V$			$0.3*V_{CC}$		V
High-Level Output Voltage	$V_{OH}$	$I_{OH}=-100\mu A$	$V_{CC}=1.65 \sim 5.5V$	$V_{CC}-0.1$			V
		$I_{OH}=-4mA$	$V_{CC}=1.65V$	1.2			V
		$I_{OH}=-8mA$	$V_{CC}=2.3V$	1.9			V
		$I_{OH}=-16mA$	$V_{CC}=3.0V$	2.4			V
		$I_{OH}=-24mA$	$V_{CC}=3.0V$	2.3			V
		$I_{OH}=-32mA$	$V_{CC}=4.5V$	3.8			V
Low-Level Output Voltage	$V_{OL}$	$I_{OL}=100\mu A$	$V_{CC}=1.65 \sim 5.5V$			0.1	V
		$I_{OL}=4mA$	$V_{CC}=1.65V$			0.45	V
		$I_{OL}=8mA$	$V_{CC}=2.3V$			0.3	V
		$I_{OL}=16mA$	$V_{CC}=3.0V$			0.4	V
		$I_{OL}=24mA$	$V_{CC}=3.0V$			0.55	V
		$I_{OL}=32mA$	$V_{CC}=4.5V$			0.55	V
Input Leakage Current	$I_{I(LEAK)}$	$V_{IN}=5.5V$ or GND, $V_{CC}=0 \sim 5.5V$				$\pm 5$	$\mu A$
Power OFF Leakage Current	$I_{OFF}$	$V_{IN}$ or $V_{OUT}=5.5V$ , $V_{CC}=0V$				$\pm 10$	$\mu A$
Quiescent Supply Current	$I_Q$	$V_{IN}=V_{CC}$ or GND, $I_{OUT}=0$ , $V_{CC}=1.65 \sim 5.5V$				10	$\mu A$
Additional Quiescent Supply Current Per Input Pin	$\Delta I_Q$	$V_{CC}=3 \sim 5.5V$ , One input at $V_{CC}-0.6V$ , Other inputs at $V_{CC}$ or GND				500	$\mu A$
Input Capacitance	$C_I$	$V_{CC}=3.3V$ , $V_{IN}=V_{CC}$ or GND			4		pF

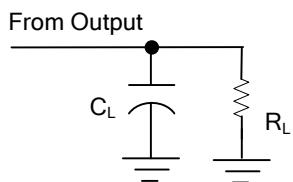
■ SWITCHING CHARACTERISTICS ( $T_A=25^\circ C$ )

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Propagation delay from input (A or B) to output(Y)	$t_{PLH} / t_{PHL}$	$V_{CC}=1.8 \pm 0.15V$	$C_L=15pF$ $R_L=1M\Omega$	2.2		7.2	ns
		$V_{CC}=2.5 \pm 0.2V$		0.9		4.4	ns
		$V_{CC}=3.3 \pm 0.3V$		0.8		3.8	ns
		$V_{CC}=5 \pm 0.5V$		0.8		3.4	ns
		$V_{CC}=1.8 \pm 0.15V$ , $R_L=1K\Omega$	$C_L=30pF$	3.1		9	ns
		$V_{CC}=2.5 \pm 0.2V$ , $R_L=500\Omega$		1.3		5.5	ns
		$V_{CC}=3.3 \pm 0.3V$ , $R_L=500\Omega$		1		4.7	ns
		$V_{CC}=5 \pm 0.5V$ , $R_L=500\Omega$		1		4	ns

■ OPERATING CHARACTERISTICS ( $T_A=25^\circ C$ )

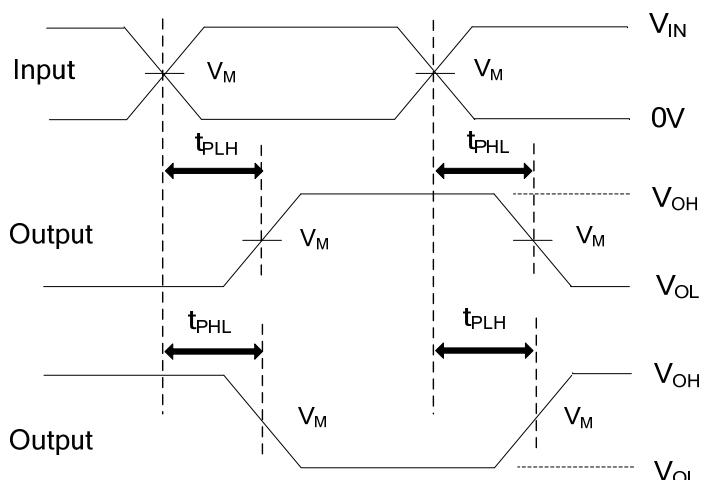
PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	$C_{PD}$	$V_{CC}=1.8V$	$f=10MHz$		22		pF
		$V_{CC}=2.5V$			22		
		$V_{CC}=3.3V$			23		
		$V_{CC}=5.0V$			25		

■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

$V_{CC}$	Inputs		$V_M$	$C_L$	$R_L$
	$V_{IN}$	$t_R, t_F$			
1.8V±0.15V	$V_{CC}$	≤2ns	$V_{CC}/2$	15pF	1MΩ
2.5V±0.2V	$V_{CC}$	≤2ns	$V_{CC}/2$	15pF	1MΩ
3.3V±0.3V	3V	≤2.5ns	1.5V	15pF	1MΩ
5V±0.5V	$V_{CC}$	≤2.5ns	$V_{CC}/2$	15pF	1MΩ

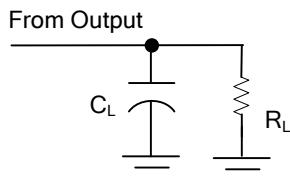


PROPAGATION DELAY TIMES

Note:  $C_L$  includes probe and jig capacitance.

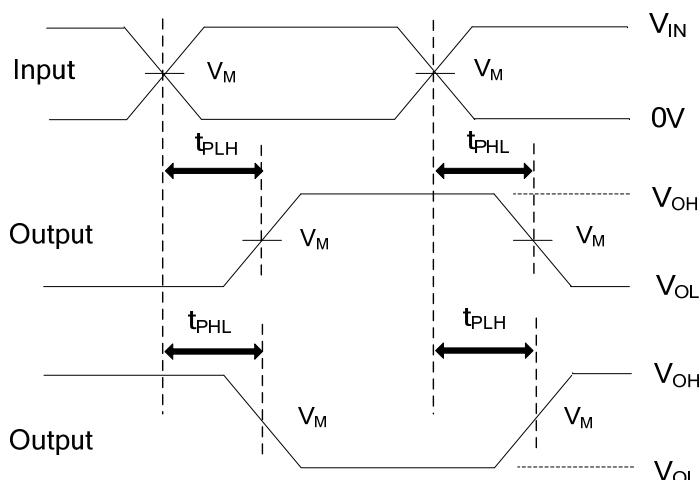
All input pulses are supplied by generators having the following characteristics:  $P_{RR} \leq 10\text{MHz}$ ,  $Z_0 = 50\Omega$ .

■ TEST CIRCUIT AND WAVEFORMS(Cont.)



TEST CIRCUIT

$V_{CC}$	Inputs		$V_M$	$C_L$	$R_L$
	$V_{IN}$	$t_R, t_F$			
1.8V±0.15V	$V_{CC}$	≤2ns	$V_{CC}/2$	30pF	1KΩ
2.5V±0.2V	$V_{CC}$	≤2ns	$V_{CC}/2$	30pF	500Ω
3.3V±0.3V	3V	≤2.5ns	1.5V	50pF	500Ω
5V±0.5V	$V_{CC}$	≤2.5ns	$V_{CC}/2$	50pF	500Ω



PROPAGATION DELAY TIMES

Note:  $C_L$  includes probe and jig capacitance.

All input pulses are supplied by generators having the following characteristics:  $P_{RR} \leq 10\text{MHz}$ ,  $Z_0 = 50\Omega$ .

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